

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HIDEHIRA ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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	N	JP2000-231123	08-2000	Japan	Nakata et al.	G02F 1/136
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NON-PATENT DOCUMENTS

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